

CUSTOMER 客户:

规格书编号

**SPEC NO:** 

# 产品规格书 SPECIFICATION

——————————————————————————————————————						
PRODUCT 产品:	SAW FILTER					
MODEL NO 型 号:	HDF914.5A F11					
PREPARED 编 制:	CHECKED 审 核:					
APPROVED 批准:	<b>DATE</b> 日 期	月:2006-5-11				
客户确认 CUSTOMER RECEIVED:						
审核 CHECKED	批准 APPROVED	日期 DATE				

无锡市好达电子有限公司 Shoulder Electronics Limited



# 更改历史记录 History Record

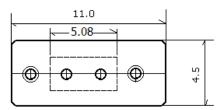
更改日期 Date	规格书编号 Spec. No.	产品型号 Part No.	客户产品型号 Customer No.	更改内容描述 Modify Content	备注 Remark

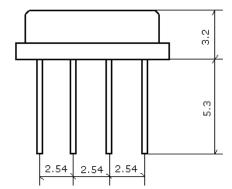


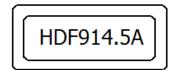
# 1. Package Dimension

Unit:mm









# 2. Marking

# **HD F914.5A**

1.Color: Black or Blue

2.914.5: Center Frequency(MHz)

# 3. Performance

3.1 Application

Low-Loss SAW Filter of cordless system.

Center Frequency:914.5MHz

3.2 Maximum Rating

Operation Temperature Range	-40°C to +85°C	
Storage Temperature Range	-40°C to +85°C	
DC. Permissive Voltage	0 V DC. max.	
Maximum Input Power	5dBm	

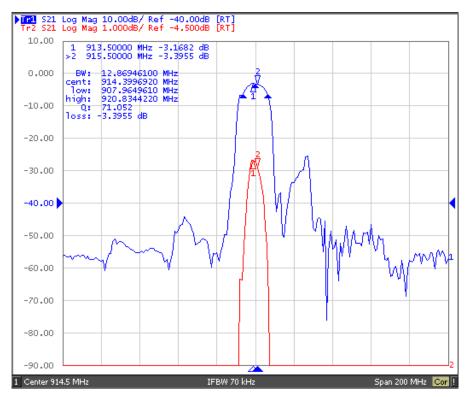


**SAW FILTER** 

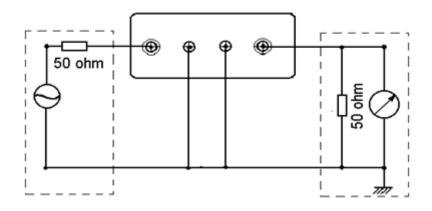
#### 3.3 Electronic Characteristics

Part number	F914.5A	Unit
Center frequency fo	914.5	MHz
Insertion Loss:		
Fo±1.0 MHz	4.5max	
Fo-20~23MHz	30.0min	dВ
Fo-40~45MHz	45.0min	uБ
Fo+20~23MHz	20.0min	
Fo+40~45MHz	35.0min	
Ripple(Fo±1.0MHz)	2.0max	dB
Input/Output impedance	50//10nH	$\Omega$ //pF

## 3.4 Frequency Characteristics



#### 3.5 Test Circuit





**SAW FILTER** 

# 4. ENVIRONMENTAL CHARACTERISTICS

#### 4-1 High temperature exposure

Subject the device to  $+85^{\circ}$ C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 3.3.

#### 4-2 Low temperature exposure

Subject the device to  $-40^{\circ}$ C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 3.3..

## 4-3 Temperature cycling

Subject the device to a low temperature of  $-40^{\circ}$ C for 30 minutes. Following by a high temperature of  $+85^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 3.3..

#### 4-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at  $260^{\circ}$ C  $\pm 10^{\circ}$ C for  $10\pm 1$  sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 3.3..

#### 4-5 Solderability

Subject the device terminals into the solder bath at  $245^{\circ}$ C  $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 3.3..

#### 4-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 3.3..

#### 4-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 3.3..

#### 5. REMARK

#### 5.1 Static voltage

Static voltage between signal load & ground may cause deterioration &destruction of the component. Please avoid static voltage.

#### 5.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

### 5.3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component.